

| | | | | |
|-----------------------------------|---------------------------------------|--|---|-------------|
| Notice of References Cited | Application/Control No. 10/697,108 | | Applicant(s)/Patent Under Reexamination BEISEL ET AL. | |
| | Examiner SIU M. LEE | | Art Unit 2611 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-6,285,475 | 09-2001 | Fee, John Arthur | 398/10 |
| * | B | US-6,597,826 | 07-2003 | Ramaswami et al. | 385/17 |
| * | C | US-5,790,520 | 08-1998 | Iwamoto et al. | 370/223 |
| * | D | US-5,390,164 | 02-1995 | Kremer, Wilhelm | 370/223 |
| * | E | US-6,205,562 | 03-2001 | Fukushima et al. | 714/43 |
| * | F | US-6,807,190 | 10-2004 | Kremer, Wilhelm | 370/452 |
| * | G | US-6,658,013 | 12-2003 | de Boer et al. | 370/404 |
| * | H | US-2002/0135835 | 09-2002 | Lauder et al. | 359/124 |
| * | I | US-5,187,706 | 02-1993 | Frankel et al. | 370/217 |
| * | J | US-7,180,867 | 02-2007 | Hoch et al. | 370/244 |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.